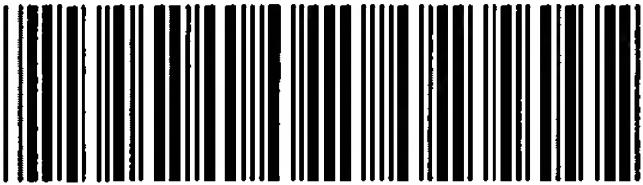


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/623,214	STAVELY ET AL.	
	Examiner	Art Unit	
	Nhan T. Tran	2622	

SEARCHED			
Class	Subclass	Date	Examiner
348	211.8	9/24/2006	NT
348	240.2	9/27/2006	NT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB) text search - see search history printout IDS considered	9/24/2006	NT
348/211.2 (text search - see search history printout)	9/24/2006	NT
348/333.01-333.12 (text search - see search history printout)	9/27/2006	NT
348/220.1 (text search - see search history printout)  Discussed with Tuan Ho and Dave Ometz	10/3/2006	NT
class 345 text search - see search history printout	10/4/2006	NT
Inventorship search	10/4/2006	NT